TEXAS INSTRUMENTS

SN74AXC4T774-Q1 具有独立方向、可配置电压转换和三态输出的汽车类 4 位双电源总线收发器

1 特性

- 符合面向汽车应用的 AEC-Q100 标准
- 完全可配置的双轨设计，实现各个端口在 0.65V 至 3.6V 的电源电压范围内运行
- 工作温度范围为 –40°C 至 +125°C
- 独立方向控制引脚，支持可配置升降转换
- 无干扰电源定序
- 从 1.8V 转换到 3.3V 时，支持高达 310Mbps 的转换速率
- VCC 隔离特性：
  - 如果任何一个 V_{CC} 输入低于 100mV，则所有 I/O 输出均禁用且处于高阻抗状态
- I_{off} 支持局部断电模式运行
- 兼容 AVC 系列电平转换器
- 闩锁性能超出 100mA，符合 JESD 78 II 类规范的要求
- ESD 保护性能超过 JEDEC JS-001 规范要求
  - 8000V 人体放电模型
  - 1000V 充电器件模型

2 应用

- 信息娱乐系统音响主机
- ADAS 融合
- ADAS 前置摄像头
- 混合动力汽车/电动汽车电池管理
- 远程信息处理控制单元

3 说明

SN74AXC4T774-Q1 是一款使用两个独立可配置电源轨的四位同相总线收发器。 VCCA 和 VCCB 电源电压低至 0.65V 时，该器件可正常工作。A 端口用于跟踪 VCCA，该端口可支持 0.65V 至 3.6V 范围内的任何电源电压。B 端口用于跟踪 VCCB，该端口也可支持 0.65V 至 3.6V 范围内的任何电源电压。此外，SN74AXC4T774-Q1 还与单电源系统兼容。

SN74AXC4T774-Q1 器件旨在实现数据总线之间的异步通信。根据方向控制输入 (DIRx) 的逻辑电平，该器件将数据从 A 总线传输至 B 总线，或者将数据从 B 总线传输至 A 总线。输出使能输入 ($\overline{OE}$) 用于禁用输出，从而有效隔离总线。 SN74AXC4T774-Q1 器件旨在使控制引脚（DIRx 和 OE）以 VCCA 为基准。

为了确保电平转换器 I/O 在上电或断电期间处于高阻抗状态，$\overline{OE}$ 引脚应通过上拉电阻器连接至 V_{CCA}。

该器件完全符合使用 Ioff 电流的部分断电应用的规范要求。当器件断电时，Ioff 保护电路可确保不从输入、输出或偏置到特定电压的组合 I/O 获取多余电流，也不向其提供多余电流。

V_{CC} 隔离特性能确保当 V_{CCA} 或 V_{CCB} 低于 100mV 时，可通过禁用 I/O 端口的输出来将其设为高阻抗状态。

无干扰电源时序使电源轨能以任何顺序打开或关断，从而提供强大的电源时序性能。

器件信息

器件型号	封装[(1)]	封装尺寸（标称值）
SN74AXC4T774QPWRQ1	TSSOP (16)	5.00mm × 4.40mm
SN74AXC4T774QBQBRQ1	WQFN (16)	2.50mm × 3.50mm
SN74AXC4T774QRSVRQ1	UQFN (16)	2.60mm x 1.80mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

功能模块图

English Data Sheet: SCES918

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4 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision C (July 2020) to Revision D (March 2021)	Page
• 将 BQB (WQFN) 封装选项的状态从预发布 更改为生产。	1

Changes from Revision B (June 2020) to Revision C (July 2020)	Page
• 向器件信息 表添加了 BQB (WQFN) 封装选项	1
• 更新了整个文档的表、图和交叉参考的编号格式	1

Changes from Revision A (April 2020) to Revision B (June 2020)	Page
• RSV 器件状态从"预发布"更改为"正在供货"	1

Changes from Revision * (February 2020) to Revision A (April 2020)	Page
• 将器件状态从"预告信息"更改为"量产数据"	1

5 Pin Configuration and Functions
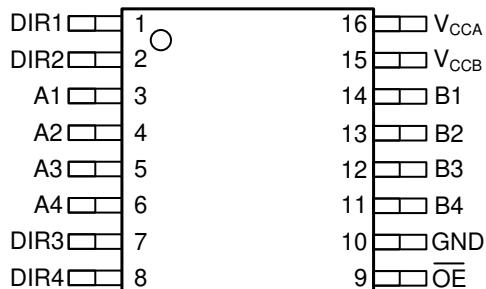
图 5-1. PW Package 16-Pin TSSOP Top View
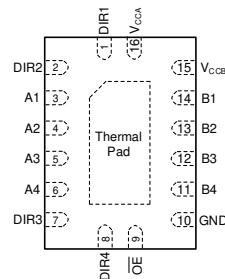
图 5-2. BQB Package 16-Pin WQFN Transparent Top View
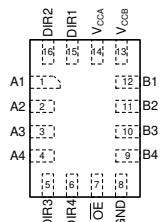
图 5-3. RSV Package 16-Pin UQFN Transparent Top View

Pin Functions

PIN	NO.			TYPE	DESCRIPTION
NAME	PW	RSV	BQB		
A1	3	1	3	I/O	Input/output A1. Referenced to V_{CCA}.
A2	4	2	4	I/O	Input/output A2. Referenced to V_{CCA}.
A3	5	3	5	I/O	Input/output A3. Referenced to V_{CCA}.
A4	6	4	6	I/O	Input/output A4. Referenced to V_{CCA}.
B1	14	12	14	I/O	Input/output B1. Referenced to V_{CCB}.
B2	13	11	13	I/O	Input/output B2. Referenced to V_{CCB}.
B3	12	10	12	I/O	Input/output B3. Referenced to V_{CCB}.
B4	11	9	11	I/O	Input/output B4. Referenced to V_{CCB}.
DIR1	1	15	1	I	Direction-control input for port 1. Referenced to V_{CCA}.
DIR2	2	16	2	I	Direction-control input for port 2. Referenced to V_{CCA}.
DIR3	7	5	7	I	Direction-control input for port 3. Referenced to V_{CCA}.
DIR4	8	6	8	I	Direction-control input for port 4. Referenced to V_{CCA}.
$\overline{OE}$	9	7	9	I	Tri-state output enable. Pull $\overline{OE}$ high to place all outputs in tri-state mode. Referenced to V_{CCA}.
GND	10	8	10	—	Ground
V_{CCA}	16	14	16	—	A-port power supply voltage. 0.65 V ⩽ V_{CCA} ⩽ 3.6 V
V_{CCB}	15	13	15	—	B-port power supply voltage. 0.65 V ⩽ V_{CCB} ⩽ 3.6 V

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

			MIN	MAX	UNIT
V_{CCA}	Supply voltage A		– 0.5	4.2	V
V_{CCB}	Supply voltage B		– 0.5	4.2	V
V_I	Input Voltage[2]	I/O Ports (A Port)	– 0.5	4.2	V
		I/O Ports (B Port)	– 0.5	4.2	
		Control Inputs	– 0.5	4.2	
V_O	Voltage applied to any output in the high-impedance or power-off state[2]	A Port	– 0.5	4.2	V
		B Port	– 0.5	4.2	
V_O	Voltage applied to any output in the high or low state[2] [3]	A Port	– 0.5	V_{CCA} + 0.2	V
		B Port	– 0.5	V_{CCB} + 0.2	
I_{IK}	Input clamp current	$V_I < 0$	– 50		mA
I_{OK}	Output clamp current	$V_O < 0$	– 50		mA
I_O	Continuous output current		– 50	50	mA
	Continuous current through V_{CC} or GND		– 100	100	mA
T_j	Junction Temperature			150	°C
T_{stg}	Storage temperature		– 65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions.* Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input voltage and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3) The output positive-voltage rating may be exceeded up to 4.2 V maximum if the output current rating is observed.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q100-002[1]	±8000	V
		Charged device model (CDM), per AEC Q100-011	±1000	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

Product Folder Links: *SN74AXC4T774-Q1*

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)[1] [2]

					MIN	MAX	UNIT
V_{CCA}	Supply voltage A				0.65	3.6	V
V_{CCB}	Supply voltage B				0.65	3.6	V
V_{IH}	High-level input voltage	Data Inputs	V_{CCI} = 0.65 V - 0.75 V	V_{CCI} x 0.70			
			V_{CCI} = 0.76 V - 1 V	V_{CCI} x 0.70			
			V_{CCI} = 1.1 V - 1.95 V	V_{CCI} x 0.65			
			V_{CCI} = 2.3 V - 2.7 V	1.6			
			V_{CCI} = 3 V - 3.6 V	2			
		Control Inputs(DIRx, $\overline{OE}$), Referenced to V_{CCA}	V_{CCA} = 0.65 V - 0.75 V	V_{CCA} x 0.70			
			V_{CCA} = 0.76 V - 1 V	V_{CCA} x 0.70			
			V_{CCA} = 1.1 V - 1.95 V	V_{CCA} x 0.65			
			V_{CCA} = 2.3 V - 2.7 V	1.6			
			V_{CCA} = 3 V - 3.6 V	2			
V_{IL}	Low-level input voltage	Data Inputs	V_{CCI} = 0.65 V - 0.75 V		V_{CCI} x 0.30		V
			V_{CCI} = 0.76 V - 1 V		V_{CCI} x 0.30		
			V_{CCI} = 1.1 V - 1.95 V		V_{CCI} x 0.35		
			V_{CCI} = 2.3 V - 2.7 V		0.7		
			V_{CCI} = 3 V - 3.6 V		0.8		
		Control Inputs(DIRx, $\overline{OE}$), Referenced to V_{CCA}	V_{CCA} = 0.65 V - 0.75 V		V_{CCA} x 0.30		
			V_{CCA} = 0.76 V - 1 V		V_{CCA} x 0.30		
			V_{CCA} = 1.1 V - 1.95 V		V_{CCA} x 0.35		
			V_{CCA} = 2.3 V - 2.7 V		0.7		
			V_{CCA} = 3 V - 3.6 V		0.8		
V_I	Input voltage[1]				0	3.6	V
V_O	Output voltage	Active State			0	V_{CCO}	V
		Tri-State			0	3.6	
$\Delta t/ \Delta v$[2]	Input transition rise and fall time					10	ns/V
T_A	Operating free-air temperature				−40	125	°C

(1) V_{CCI} is the V_{CC} associated with the input port. V_{CCO} is the V_{CC} associated with the output port.
(2)   All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, SCBA004.

6.4 Thermal Information

THERMAL METRIC[1]		SN74AXC4T774-Q1			UNIT
		PW (TSSOP)	RSV (UQFN)	BQB (WQFN)	
		16 PINS	16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	118.2	130.8	73.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	48.6	69.1	70.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	64.5	59.9	43.5	°C/W
Y_{JT}	Junction-to-top characterization parameter	7.3	3.9	4.9	°C/W
Y_{JB}	Junction-to-board characterization parameter	63.9	58.3	43.5	°C/W
$R_{\theta JC(bottom)}$	Junction-to-case (bottom) thermal resistance	NA	NA	21.2	°C/W

(1)   For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted) [1] [2] [4]

PARAMETER		TEST CONDITIONS		V_{CCA}	V_{CCB}	Operating free-air temperature (T_A)						UNIT
						−40°C to 85°C			−40°C to 125°C			
						MIN	TYP	MAX	MIN	TYP	MAX	
V_{OH}	High-level output voltage	$V_I = V_{IH}$	$I_{OH} = -100\ \mu A$	0.7 V - 3.6 V	0.7 V - 3.6 V	$V_{CCO} - 0.1$			$V_{CCO} - 0.1$			V
			$I_{OH} = -50\ \mu A$	0.65 V	0.65 V	0.55			0.55			
			$I_{OH} = -200\ \mu A$	0.76 V	0.76 V	0.58			0.58			
			$I_{OH} = -500\ \mu A$	0.85 V	0.85 V	0.65			0.65			
			$I_{OH} = -3\ mA$	1.1 V	1.1 V	0.85			0.85			
			$I_{OH} = -6\ mA$	1.4 V	1.4 V	1.05			1.05			
			$I_{OH} = -8\ mA$	1.65 V	1.65 V	1.2			1.2			
			$I_{OH} = -9\ mA$	2.3 V	2.3 V	1.75			1.75			
			$I_{OH} = -12\ mA$	3 V	3 V	2.3			2.3			
V_{OL}	Low-level output voltage	$V_I = V_{IL}$	$I_{OL} = 100\ \mu A$	0.7 V - 3.6 V	0.7 V - 3.6 V			0.1			0.1	V
			$I_{OL} = 50\ \mu A$	0.65 V	0.65 V			0.1			0.1	
			$I_{OL} = 200\ \mu A$	0.76 V	0.76 V			0.18			0.18	
			$I_{OL} = 500\ \mu A$	0.85 V	0.85 V			0.2			0.2	
			$I_{OL} = 3\ mA$	1.1 V	1.1 V			0.25			0.25	
			$I_{OL} = 6\ mA$	1.4 V	1.4 V			0.35			0.35	
			$I_{OL} = 8\ mA$	1.65 V	1.65 V			0.45			0.45	
			$I_{OL} = 9\ mA$	2.3 V	2.3 V			0.55			0.55	
			$I_{OL} = 12\ mA$	3 V	3 V			0.7			0.7	
I_I	Input leakage current	Control inputs (DIRx, $\overline{OE}$):$V_I = V_{CCA}$ or GND		0.65 V- 3.6 V	0.65 V- 3.6 V	−0.5		0.5	−1		1	µA
		Data Inputs (Ax, Bx),$V_I = V_{CCI}$ or GND		0.65 V- 3.6 V	0.65 V- 3.6 V	−4		4	−8		8	µA
I_{off}	Partial power down current	A Port: V_I or $V_O = 0\ V - 3.6\ V$		0 V	0 V - 3.6 V	−4		4	−8		8	µA
		B Port: V_I or $V_O = 0\ V - 3.6\ V$		0 V - 3.6 V	0 V	−4		4	−8		8	
I_{OZ}	Tri-state output current [3]	A or B Port, $V_I = V_{CCI}$ or GND, $V_O = V_{CCO}$ or GND, $\overline{OE} = V_{IH}$		3.6 V	3.6 V	−4		4	−8		8	µA
I_{CCA}	V_{CCA} supply current	$V_I = V_{CCI}$ or GND	$I_O = 0$	0.65 V- 3.6 V	0.65 V- 3.6 V			15			27	µA
				0 V	3.6 V	−2			−12			
				3.6 V	0 V			10			18	
I_{CCB}	V_{CCB} supply current	$V_I = V_{CCI}$ or GND	$I_O = 0$	0.65 V- 3.6 V	0.65 V- 3.6 V			15			27	µA
				0 V	3.6 V			10			18	
				3.6 V	0 V	−2			−12			
$I_{CCA} + I_{CCB}$	Combined supply current	$V_I = V_{CCI}$ or GND	$I_O = 0$	0.65 V- 3.6 V	0.65 V- 3.6 V			21			40	µA
C_i	Control Input Capacitance	$V_I = 3.3\ V$ or GND		3.3 V	3.3 V		4.5			4.5		pF
C_{io}	Data I/O Capacitance	$\overline{OE} = V_{CCA}$, $V_O = 1.65V\ DC +1$ MHz -16 dBm sine wave		3.3 V	3.3 V		6.5			6.5		pF

(1) V_{CCI} is the V_{CC} associated with the input port.
(2) V_{CCO} is the V_{CC} associated with the output port.
(3) For I/O ports, the parameter I_{OZ} includes the input leakage current.
(4) All typical data is taken at 25°C.

Product Folder Links: *SN74AXC4T774-Q1*

6.6 Switching Characteristics, V_{CCA} = 0.7 ± 0.05 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B – Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	172	0.5	120	0.5	88	0.5	51	0.5	46	0.5	56	0.5	78	0.5	221	ns
				−40°C to 125°C	0.5	172	0.5	120	0.5	88	0.5	51	0.5	46	0.5	56	0.5	78	0.5	221	
		B	A	−40°C to 85°C	0.5	172	0.5	141	0.5	109	0.5	51	0.5	16	0.5	12	0.5	9	0.5	9	
				−40°C to 125°C	0.5	172	0.5	141	0.5	109	0.5	51	0.5	16	0.5	12	0.5	9	0.5	9	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	ns
				−40°C to 125°C	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	0.5	205	
		$\overline{OE}$	B	−40°C to 85°C	0.5	189	0.5	161	0.5	145	0.5	102	0.5	99	0.5	102	0.5	113	0.5	176	
				−40°C to 125°C	0.5	189	0.5	161	0.5	145	0.5	102	0.5	99	0.5	102	0.5	113	0.5	176	
t_{en}	Enable time	$\overline{OE}$	A	−40°C to 85°C	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	ns
				−40°C to 125°C	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	0.5	287	
		$\overline{OE}$	B	−40°C to 85°C	0.5	309	0.5	219	0.5	177	0.5	133	0.5	127	0.5	132	0.5	165	0.5	418	
				−40°C to 125°C	0.5	309	0.5	219	0.5	177	0.5	133	0.5	127	0.5	132	0.5	165	0.5	418	

6.7 Switching Characteristics, V_{CCA} = 0.8 ± 0.04 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	141	0.5	96	0.5	73	0.5	39	0.5	29	0.5	28	0.5	29	0.5	40	ns
				−40°C to 125°C	0.5	141	0.5	96	0.5	73	0.5	39	0.5	29	0.5	28	0.5	29	0.5	40	
		B	A	−40°C to 85°C	0.5	120	0.5	96	0.5	76	0.5	39	0.5	16	0.5	11	0.5	9	0.5	9	
				−40°C to 125°C	0.5	120	0.5	96	0.5	76	0.5	39	0.5	16	0.5	12	0.5	9	0.5	9	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	ns
				−40°C to 125°C	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	0.5	114	
		$\overline{OE}$	B	−40°C to 85°C	0.5	156	0.5	131	0.5	116	0.5	71	0.5	67	0.5	68	0.5	70	0.5	84	
				−40°C to 125°C	0.5	156	0.5	131	0.5	116	0.5	71	0.5	67	0.5	68	0.5	70	0.5	84	

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{en}	Enable time	$\overline{OE}$	A	−40°C to 85°C	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	ns
				−40°C to 125°C	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	0.5	161	
		$\overline{OE}$	B	−40°C to 85°C	0.5	258	0.5	174	0.5	137	0.5	90	0.5	73	0.5	71	0.5	77	0.5	106	
				−40°C to 125°C	0.5	258	0.5	174	0.5	137	0.5	90	0.5	73	0.5	71	0.5	77	0.5	106	

6.8 Switching Characteristics, V_{CCA} = 0.9 ± 0.045 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	109	0.5	76	0.5	60	0.5	33	0.5	23	0.5	21	0.5	21	0.5	24	ns
				−40°C to 125°C	0.5	109	0.5	76	0.5	60	0.5	33	0.5	23	0.5	21	0.5	21	0.5	24	
		B	A	−40°C to 85°C	0.5	88	0.5	73	0.5	60	0.5	33	0.5	16	0.5	11	0.5	9	0.5	9	
				−40°C to 125°C	0.5	88	0.5	73	0.5	60	0.5	33	0.5	16	0.5	12	0.5	9	0.5	9	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	ns
				−40°C to 125°C	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	0.5	83	
		$\overline{OE}$	B	−40°C to 85°C	0.5	138	0.5	112	0.5	97	0.5	51	0.5	46	0.5	46	0.5	46	0.5	54	
				−40°C to 125°C	0.5	138	0.5	112	0.5	97	0.5	51	0.5	46	0.5	46	0.5	46	0.5	54	
t_{en}	Enable time	$\overline{OE}$	A	−40°C to 85°C	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	ns
				−40°C to 125°C	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	0.5	94	
		$\overline{OE}$	B	−40°C to 85°C	0.5	203	0.5	140	0.5	110	0.5	70	0.5	52	0.5	45	0.5	43	0.5	51	
				−40°C to 125°C	0.5	203	0.5	140	0.5	110	0.5	74	0.5	54	0.5	47	0.5	43	0.5	51	

Product Folder Links: SN74AXC4T774-Q1

6.9 Switching Characteristics, V_{CCA} = 1.2 ± 0.1 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	50	0.5	39	0.5	33	0.5	20	0.5	14	0.5	12	0.5	10	0.5	12	ns
				−40°C to 125°C	0.5	50	0.5	39	0.5	33	0.5	20	0.5	14	0.5	12	0.5	10	0.5	12	
		B	A	−40°C to 85°C	0.5	51	0.5	39	0.5	33	0.5	20	0.5	15	0.5	11	0.5	8	0.5	7	
				−40°C to 125°C	0.5	51	0.5	39	0.5	33	0.5	20	0.5	15	0.5	12	0.5	8	0.5	7	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	28	0.5	28	0.5	28	0.5	28	0.5	28	0.5	28	0.5	28	0.5	28	ns
				−40°C to 125°C	0.5	29	0.5	29	0.5	29	0.5	29	0.5	29	0.5	29	0.5	29	0.5	29	
		$\overline{OE}$	B	−40°C to 85°C	0.5	123	0.5	95	0.5	78	0.5	33	0.5	26	0.5	25	0.5	23	0.5	26	
				−40°C to 125°C	0.5	124	0.5	95	0.5	79	0.5	34	0.5	27	0.5	26	0.5	24	0.5	26	
t_{en}	Enable time	$\overline{OE}$	A	−40°C to 85°C	0.5	39	0.5	39	0.5	39	0.5	39	0.5	39	0.5	39	0.5	39	0.5	39	ns
				−40°C to 125°C	0.5	40	0.5	40	0.5	40	0.5	40	0.5	40	0.5	40	0.5	40	0.5	40	
		$\overline{OE}$	B	−40°C to 85°C	0.5	124	0.5	87	0.5	70	0.5	51	0.5	38	0.5	33	0.5	26	0.5	25	
				−40°C to 125°C	0.5	124	0.5	87	0.5	70	0.5	55	0.5	42	0.5	36	0.5	28	0.5	26	

6.10 Switching Characteristics, V_{CCA} = 1.5 ± 0.1 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	16	0.5	16	0.5	16	0.5	15	0.5	11	0.5	10	0.5	8	0.5	10	ns
				−40°C to 125°C	0.5	16	0.5	16	0.5	16	0.5	15	0.5	11	0.5	10	0.5	8	0.5	10	
		B	A	−40°C to 85°C	0.5	47	0.5	29	0.5	23	0.5	14	0.5	11	0.5	9	0.5	7	0.5	6	
				−40°C to 125°C	0.5	47	0.5	29	0.5	23	0.5	14	0.5	11	0.5	9	0.5	7	0.5	6	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	ns
				−40°C to 125°C	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	
		$\overline{OE}$	B	−40°C to 85°C	0.5	120	0.5	91	0.5	74	0.5	29	0.5	22	0.5	20	0.5	20	0.5	20	
				−40°C to 125°C	0.5	120	0.5	92	0.5	75	0.5	30	0.5	23	0.5	22	0.5	19	0.5	20	

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{en}	Enable time	$\overline{OE}$	A	− 40°C to 85°C	0.5	24	0.5	24	0.5	24	0.5	24	0.5	24	0.5	24	0.5	24	0.5	24	ns
				− 40°C to 125°C	0.5	25	0.5	25	0.5	25	0.5	25	0.5	25	0.5	25	0.5	25	0.5	25	
		$\overline{OE}$	B	− 40°C to 85°C	0.5	28	0.5	29	0.5	33	0.5	41	0.5	31	0.5	27	0.5	22	0.5	19	
				− 40°C to 125°C	0.5	29	0.5	30	0.5	33	0.5	42	0.5	33	0.5	29	0.5	24	0.5	21	

6.11 Switching Characteristics, V_{CCA} = 1.8 ± 0.15 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	− 40°C to 85°C	0.5	12	0.5	11	0.5	11	0.5	11	0.5	9	0.5	8	0.5	7	0.5	7	ns
				− 40°C to 125°C	0.5	12	0.5	12	0.5	12	0.5	12	0.5	9	0.5	9	0.5	7	0.5	7	
		B	A	− 40°C to 85°C	0.5	56	0.5	28	0.5	21	0.5	12	0.5	10	0.5	8	0.5	6	0.5	5	
				− 40°C to 125°C	0.5	56	0.5	28	0.5	21	0.5	12	0.5	10	0.5	9	0.5	7	0.5	6	
t_{dis}	Disable time	$\overline{OE}$	A	− 40°C to 85°C	0.5	17	0.5	17	0.5	17	0.5	17	0.5	17	0.5	17	0.5	17	0.5	17	ns
				− 40°C to 125°C	0.5	18	0.5	18	0.5	18	0.5	18	0.5	18	0.5	18	0.5	18	0.5	18	
		$\overline{OE}$	B	− 40°C to 85°C	0.5	117	0.5	90	0.5	73	0.5	28	0.5	21	0.5	19	0.5	16	0.5	18	
				− 40°C to 125°C	0.5	119	0.5	90	0.5	74	0.5	29	0.5	22	0.5	20	0.5	17	0.5	18	
t_{en}	Enable time	$\overline{OE}$	A	− 40°C to 85°C	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	0.5	19	ns
				− 40°C to 125°C	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	0.5	20	
		$\overline{OE}$	B	− 40°C to 85°C	0.5	21	0.5	20	0.5	20	0.5	32	0.5	27	0.5	24	0.5	20	0.5	18	
				− 40°C to 125°C	0.5	22	0.5	22	0.5	22	0.5	34	0.5	29	0.5	26	0.5	22	0.5	19	

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6.12 Switching Characteristics, V_{CCA} = 2.5 ± 0.2 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Conditions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	10	0.5	10	0.5	9	0.5	8	0.5	7	0.5	6	0.5	6	0.5	6	ns
				−40°C to 125°C	0.5	10	0.5	10	0.5	9	0.5	8	0.5	7	0.5	7	0.5	6	0.5	6	
		B	A	−40°C to 85°C	0.5	78	0.5	30	0.5	21	0.5	10	0.5	8	0.5	7	0.5	6	0.5	5	
				−40°C to 125°C	0.5	78	0.5	30	0.5	21	0.5	10	0.5	8	0.5	7	0.5	6	0.5	5	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	ns
				−40°C to 125°C	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	
		$\overline{OE}$	B	−40°C to 85°C	0.5	115	0.5	89	0.5	72	0.5	26	0.5	19	0.5	18	0.5	14	0.5	17	
				−40°C to 125°C	0.5	117	0.5	89	0.5	72	0.5	28	0.5	21	0.5	19	0.5	15	0.5	17	
t_{en}	Enable time	$\overline{OE}$	A	−40°C to 85°C	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	0.5	14	ns
				−40°C to 125°C	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	
		$\overline{OE}$	B	−40°C to 85°C	0.5	15	0.5	14	0.5	13	0.5	14	0.5	15	0.5	16	0.5	15	0.5	15	
				−40°C to 125°C	0.5	16	0.5	15	0.5	15	0.5	16	0.5	17	0.5	18	0.5	17	0.5	16	

6.13 Switching Characteristics, V_{CCA} = 3.3 ± 0.3 V

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Condtions	B-Port Supply Voltage (V_{CCB})																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{pd}	Propagation delay	A	B	−40°C to 85°C	0.5	10	0.5	9	0.5	9	0.5	8	0.5	6	0.5	6	0.5	5	0.5	5	ns
				−40°C to 125°C	0.5	10	0.5	9	0.5	9	0.5	8	0.5	6	0.5	6	0.5	5	0.5	5	
		B	A	−40°C to 85°C	0.5	221	0.5	40	0.5	24	0.5	12	0.5	10	0.5	7	0.5	6	0.5	5	
				−40°C to 125°C	0.5	221	0.5	40	0.5	24	0.5	12	0.5	10	0.5	7	0.5	6	0.5	5	
t_{dis}	Disable time	$\overline{OE}$	A	−40°C to 85°C	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	ns
				−40°C to 125°C	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	0.5	16	
		$\overline{OE}$	B	−40°C to 85°C	0.5	115	0.5	89	0.5	72	0.5	26	0.5	19	0.5	17	0.5	14	0.5	16	
				−40°C to 125°C	0.5	117	0.5	89	0.5	72	0.5	27	0.5	20	0.5	18	0.5	14	0.5	16	

See Figure 5 and Table 1 for test circuit and loading. See Figure 6, Figure 7, and Figure 8 for measurement waveforms.

PARAMETER		FROM	TO	Test Condtions	B-Port Supply Voltage (V_CCB)																UNIT
					0.7 ± 0.05 V		0.8 ± 0.04 V		0.9 ± 0.045 V		1.2 ± 0.1 V		1.5 ± 0.1 V		1.8 ± 0.15 V		2.5 ± 0.2 V		3.3 ± 0.3 V		
					MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{en}	Enable time	$\overline{OE}$	A	– 40°C to 85°C	0.5	12	0.5	12	0.5	12	0.5	12	0.5	12	0.5	12	0.5	12	0.5	12	ns
				– 40°C to 125°C	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	0.5	13	
		$\overline{OE}$	B	– 40°C to 85°C	0.5	13	0.5	12	0.5	11	0.5	11	0.5	11	0.5	12	0.5	12	0.5	12	
				– 40°C to 125°C	0.5	14	0.5	12	0.5	12	0.5	12	0.5	12	0.5	13	0.5	13	0.5	13	

Product Folder Links: *SN74AXC4T774-Q1*

6.14 Operating Characteristics: T_A = 25°C

	PARAMETER	TEST CONDITIONS	V_{CCA}	V_{CCB}	MIN	TYP	MAX	UNIT
C_{pdA}	Power Dissipation Capacitance per transceiver (A to B: outputs enabled)	C_L = 0, R_L = Open f = 1 MHz t_{rise} = t_{fall} = 1 ns	0.7 V	0.7 V		2.4		pF
			0.8 V	0.8 V		2.3		
			0.9 V	0.9 V		2.2		
			1.2 V	1.2 V		2.2		
			1.5 V	1.5 V		2.2		
			1.8 V	1.8 V		2.2		
			2.5 V	2.5 V		2.4		
			3.3 V	3.3 V		3.0		
	Power Dissipation Capacitance per transceiver (A to B: outputs disabled)	C_L = 0, R_L = Open f = 1 MHz t_{rise} = t_{fall} = 1 ns	0.7 V	0.7 V		1.5		pF
			0.8 V	0.8 V		1.5		
			0.9 V	0.9 V		1.5		
			1.2 V	1.2 V		1.5		
			1.5 V	1.5 V		1.5		
			1.8 V	1.8 V		1.5		
			2.5 V	2.5 V		1.6		
			3.3 V	3.3 V		2.0		
	Power Dissipation Capacitance per transceiver (B to A: outputs enabled)	C_L = 0, R_L = Open f = 1 MHz t_{rise} = t_{fall} = 1 ns	0.7 V	0.7 V		13.4		pF
			0.8 V	0.8 V		15.0		
			0.9 V	0.9 V		14.0		
			1.2 V	1.2 V		20.7		
			1.5 V	1.5 V		29.6		
			1.8 V	1.8 V		40.2		
			2.5 V	2.5 V		65.8		
			3.3 V	3.3 V		91.7		
	Power Dissipation Capacitance per transceiver (B to A: outputs disabled)	C_L = 0, R_L = Open f = 1 MHz t_{rise} = t_{fall} = 1 ns	0.7 V	0.7 V		1.3		pF
			0.8 V	0.8 V		1.1		
			0.9 V	0.9 V		1.1		
			1.2 V	1.2 V		1.0		
			1.5 V	1.5 V		1.0		
			1.8 V	1.8 V		1.0		
			2.5 V	2.5 V		1.0		
			3.3 V	3.3 V		1.0		

	PARAMETER	TEST CONDITIONS	V_{CCA}	V_{CCB}	MIN	TYP	MAX	UNIT
C_{pdB}	Power Dissipation Capacitance per transceiver (A to B: outputs enabled)	$C_L = 0$, R_L = Open f = 1 MHz $t_{rise} = t_{fall}$ = 1 ns	0.7 V	0.7 V		13.4		pF
			0.8 V	0.8 V		13.8		
			0.9 V	0.9 V		14.9		
			1.2 V	1.2 V		20.6		
			1.5 V	1.5 V		29.6		
			1.8 V	1.8 V		40.3		
			2.5 V	2.5 V		66.2		
			3.3 V	3.3 V		92.5		
	Power Dissipation Capacitance per transceiver (A to B: outputs disabled)	$C_L = 0$, R_L = Open f = 1 MHz $t_{rise} = t_{fall}$ = 1 ns	0.7 V	0.7 V		1.3		pF
			0.8 V	0.8 V		1.2		
			0.9 V	0.9 V		1.1		
			1.2 V	1.2 V		1.1		
			1.5 V	1.5 V		1.1		
			1.8 V	1.8 V		1.1		
			2.5 V	2.5 V		1.1		
			3.3 V	3.3 V		1.1		
	Power Dissipation Capacitance per transceiver (B to A: outputs enabled)	$C_L = 0$, R_L = Open f = 1 MHz $t_{rise} = t_{fall}$ = 1 ns	0.7 V	0.7 V		2.5		pF
			0.8 V	0.8 V		2.4		
			0.9 V	0.9 V		2.3		
			1.2 V	1.2 V		2.2		
			1.5 V	1.5 V		2.3		
			1.8 V	1.8 V		2.3		
			2.5 V	2.5 V		2.5		
			3.3 V	3.3 V		3.0		
	Power Dissipation Capacitance per transceiver (B to A: outputs disabled)	$C_L = 0$, R_L = Open f = 1 MHz $t_{rise} = t_{fall}$ = 1 ns	0.7 V	0.7 V		1.6		pF
			0.8 V	0.8 V		1.5		
			0.9 V	0.9 V		1.5		
			1.2 V	1.2 V		1.5		
			1.5 V	1.5 V		1.5		
			1.8 V	1.8 V		1.5		
			2.5 V	2.5 V		1.6		
			3.3 V	3.3 V		2.0		

Product Folder Links: *SN74AXC4T774-Q1*

6.15 Typical Characteristics
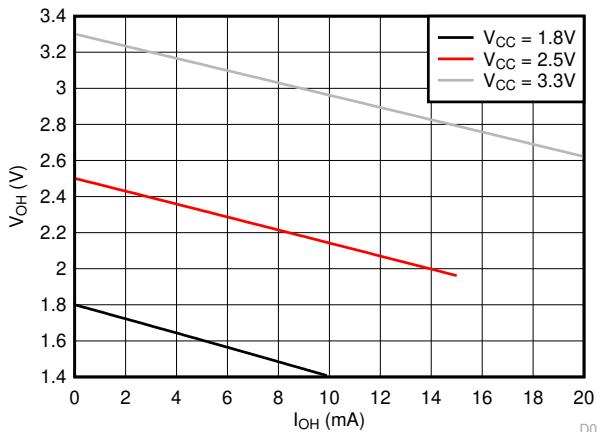
图 6-1. Typical (T_A=25°C) Output High Voltage (V_{OH}) vs Source Current (I_{OH})
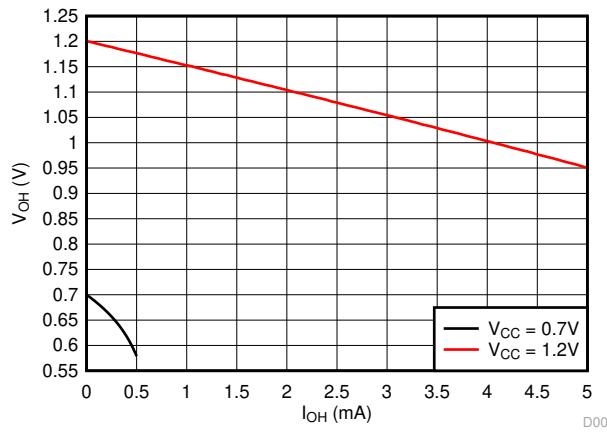
图 6-2. Typical (T_A=25°C) Output High Voltage (V_{OH}) vs Source Current (I_{OH})
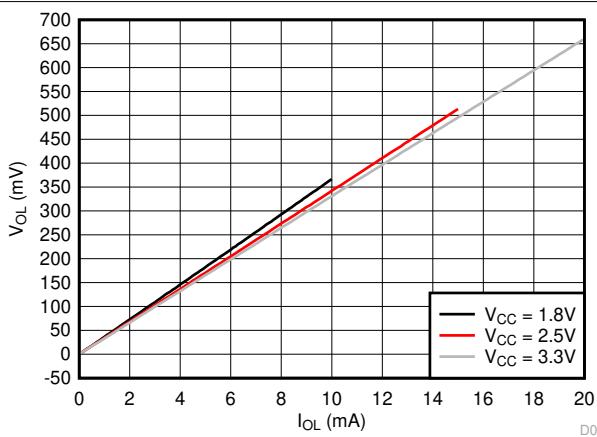
图 6-3. Typical (T_A=25°C) Output High Voltage (V_{OL}) vs Sink Current (I_{OL})
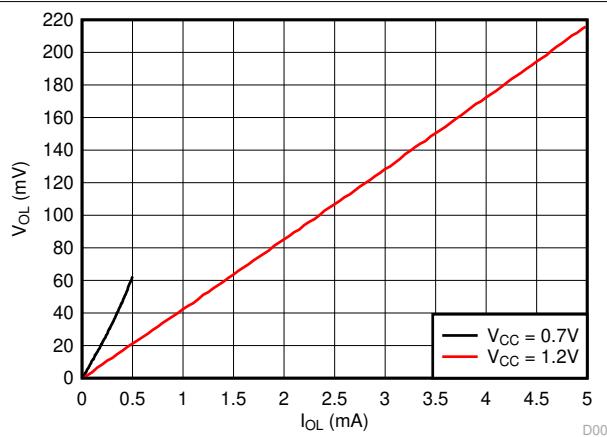
图 6-4. Typical (T_A=25°C) Output High Voltage (V_{OL}) vs Sink Current (I_{OL})

7 Parameter Measurement Information

7.1 Load Circuit and Voltage Waveforms

Unless otherwise noted, all input pulses are supplied by generators having the following characteristics:

- f = 1 MHz
- Z_O = 50 Ω
- dv/dt ⩽ 1 ns/V
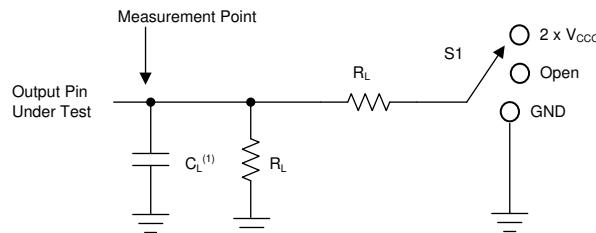
A. C_L includes probe and jig capacitance.

图 7-1. Load Circuit

表 7-1. Load Circuit Conditions

	Parameter	V_{CCO}	R_L	C_L	S_1	V_{TP}
$\Delta t/ \Delta v$	Input transition rise or fall rate	0.65 V – 3.6 V	1 MΩ	15 pF	Open	N/A
t_{pd}	Propagation (delay) time	1.1 V – 3.6 V	2 kΩ	15 pF	Open	N/A
		0.65 V – 0.95 V	20 kΩ	15 pF	Open	N/A
t_{en}, t_{dis}	Enable time, disable time	3 V – 3.6 V	2 kΩ	15 pF	2 × V_{CCO}	0.3 V
		1.65 V – 2.7 V	2 kΩ	15 pF	2 × V_{CCO}	0.15 V
		1.1 V – 1.6 V	2 kΩ	15 pF	2 × V_{CCO}	0.1 V
		0.65 V – 0.95 V	20 kΩ	15 pF	2 × V_{CCO}	0.1 V
t_{en}, t_{dis}	Enable time, disable time	3 V – 3.6 V	2 kΩ	15 pF	GND	0.3 V
		1.65 V – 2.7 V	2 kΩ	15 pF	GND	0.15 V
		1.1 V – 1.6 V	2 kΩ	15 pF	GND	0.1 V
		0.65 V – 0.95 V	20 kΩ	15 pF	GND	0.1 V

1. V_{CCI} is the supply pin associated with the input port.
2. V_{OH} and V_{OL} are typical output voltage levels that occur with specified R_L, C_L, and S_1

图 7-2. Propagation Delay

1. V_{CCI} is the supply pin associated with the input port.
2. V_{OH} and V_{OL} are typical output voltage levels that occur with specified R_L, C_L, and S_1

图 7-3. Input Transition Rise or Fall Rate

Product Folder Links: SN74AXC4T774-Q1

A. Output waveform on the condition that input is driven to a valid Logic Low.

B. Output waveform on the condition that input is driven to a valid Logic High.

C. V_{CCO} is the supply pin associated with the output port.

D. V_{OH} and V_{OL} are typical output voltage levels with specified R_L, C_L, and S_1.

图 7-4. Enable Time And Disable Time

Product Folder Links: SN74AXC4T774-Q1

8 Detailed Description

8.1 Overview

The SN74AXC4T774-Q1 is a 4-bit, dual-supply noninverting bidirectional voltage level translation device. Ax pins and control pins (DIRx and $\overline{OE}$) are reference to V_{CCA} logic levels, and Bx pins are referenced to V_{CCB} logic levels. The A port is able to accept I/O voltages ranging from 0.65 V to 3.6 V, while the B port can accept I/O voltages from 0.65 V to 3.6 V. A high on DIR allows data transmission from A to B and a low on DIR allows data transmission from B to A when $\overline{OE}$ is set to low. When $\overline{OE}$ is set to high, both Ax and Bx pins are in the high-impedance state. See 节 8.4 for a summary of the operation of the control logic.

8.2 Functional Block Diagram
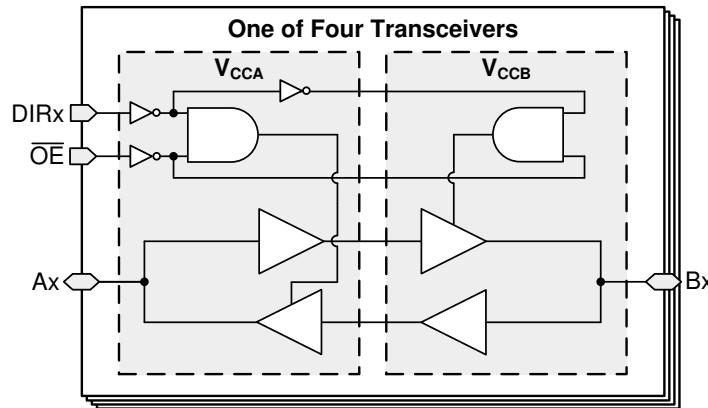
8.3 Feature Description

8.3.1 Standard CMOS Inputs

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using ohm's law (R = V ÷ I).

Signals applied to the inputs need to have fast edge rates, as defined by $\Delta t/\Delta v$ in *Recommended Operating Conditions* to avoid excessive current consumption and oscillations. If a slow or noisy input signal is required, a device with a Schmitt-trigger input should be used to condition the input signal prior to the standard CMOS input.

8.3.2 Balanced High-Drive CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The high drive capability of this device creates fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

8.3.3 Partial Power Down (I_{off})

The inputs and outputs for this device enter a high-impedance state when the device is powered down, inhibiting current backflow into the device. The maximum leakage into or out of any input or output pin on the device is specified by I_{off} in the *Electrical Characteristics*.

8.3.4 V_{CC} Isolation

The inputs and outputs for this device enter a high-impedance state when either supply is <100 mV.

8.3.5 Over-voltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as they remain below the maximum input voltage value specified in the *Recommended Operating Conditions*.

Product Folder Links: *SN74AXC4T774-Q1*

8.3.6 Glitch-free Power Supply Sequencing

Either supply rail may be powered on or off in any order without producing a glitch on the I/Os (that is, where the output erroneously transitions to VCC when it should be held low). Glitches of this nature can be misinterpreted by a peripheral as a valid data bit, which could trigger a false device reset of the peripheral, a false device configuration of the peripheral, or even a false data initialization by the peripheral. For more information regarding the power up glitch performance of the AXC family of level translators, see the *Glitch Free Power Sequencing With AXC Level Translators* application report

8.3.7 Negative Clamping Diodes

The inputs and outputs to this device have negative clamping diodes as depicted in 图 8-1.

CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
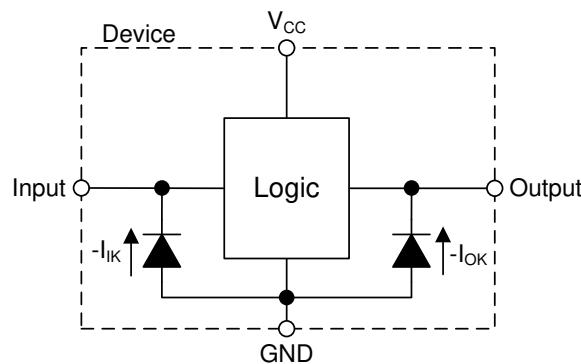
图 **8-1. Electrical Placement of Clamping Diodes for Each Input and Output**

8.3.8 Fully Configurable Dual-Rail Design

The V_{CCA} and V_{CCB} pins can be supplied at any voltage from 0.65 V to 3.6 V, making the device suitable for translating between any of the voltage nodes (0.7 V, 0.8 V, 0.9 V, 1.2 V, 1.8 V, 2.5 V, and 3.3 V).

8.3.9 Supports High-Speed Translation

The SN74AXC4T774-Q1 device can support high data-rate applications. The translated signal data rate can be up to 310 Mbps when the signal is translated from 1.8 V to 3.3 V.

8.4 Device Functional Modes

表 **8-1. Function Table**
(Each Transceiver)

CONTROL INPUTS[1] [2]		Port Status		OPERATION
$\overline{OE}$	DIR	A PORT	B PORT	
L	L	Output (Enabled)	Input (Hi-Z)	B data to A bus
L	H	Input (Hi-Z)	Output (Enabled)	A data to B bus
H	X	Input (Hi-Z)	Input (Hi-Z)	Isolation

(1)   Input circuits of the data I/Os are always active.
(2)   Pins configured as inputs should not be left floating.

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74AXC4T774-Q1 device can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The SN74AXC4T774-Q1 device is ideal for use in applications where a push-pull driver is connected to the data I/Os. The max data rate can be up to 310 Mbps when device translates a signal from 1.8 V to 3.3 V.

One example application is shown in 图 9-1, where the SN74AXC4T774-Q1 device is used to translate a low voltage SPI signal from an SoC to a higher voltage signal to properly drive the inputs of a GPS module, and vice versa.

9.2 Typical Application
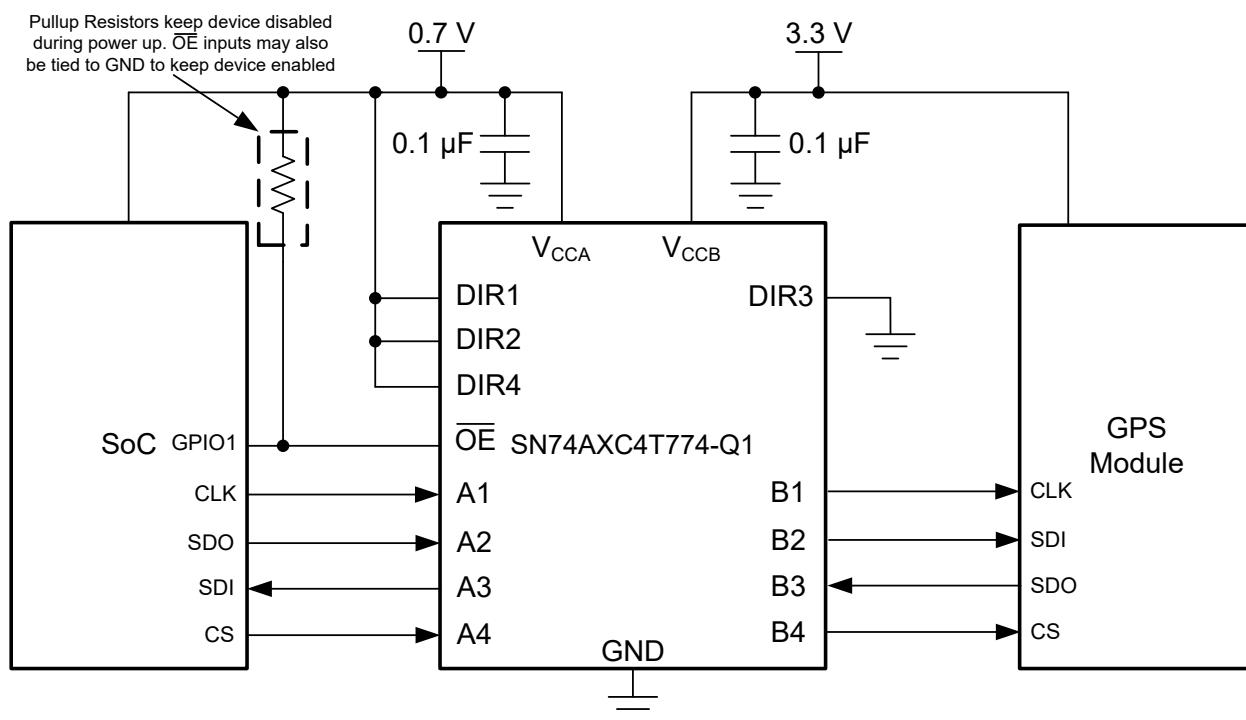
图 **9-1. Serial Peripheral Interface (SPI) Application**

9.2.1 Design Requirements

For this design example, use the parameters listed in 表 9-1.

表 **9-1. Design Parameters**

DESIGN PARAMETERS	EXAMPLE VALUES
Input voltage range	0.65 V to 3.6 V
Output voltage range	0.65 V to 3.6 V

Product Folder Links: *SN74AXC4T774-Q1*

9.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
  - Use the supply voltage of the device that is driving the SN74AXC4T774-Q1 device to determine the input voltage range. For a valid logic-high, the value must exceed the high-level input voltage (V_{IH}) of the input port. For a valid logic low the value must be less than the low-level input voltage (V_{IL}) of the input port.
- Output voltage range
  - Use the supply voltage of the device that the SN74AXC4T774-Q1 device is driving to determine the output voltage range.

9.2.3 Application Curve
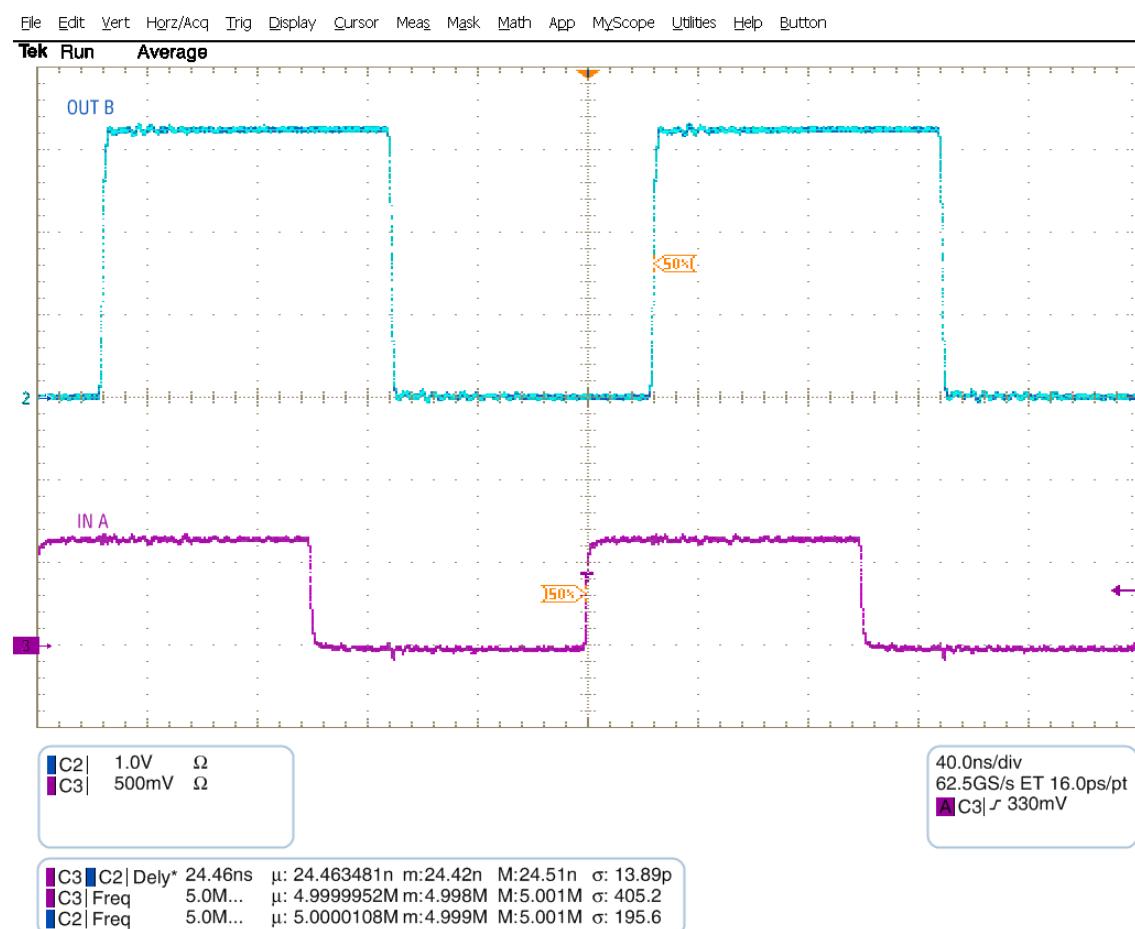
图 9-2. Up Translation at 2.5 MHz (0.7 V to 3.3 V)

10 Power Supply Recommendations

Always apply a ground reference to the GND pins first. This device is designed for glitch free power sequencing without any supply sequencing requirements such as ramp order or ramp rate.

This device was designed with various power supply sequencing methods in mind to help prevent unintended triggering of downstream devices. For more information regarding the power up glitch performance of the AXC family of level translators, see the *Glitch Free Power Sequencing With AXC Level Translators* application report

11 Layout

11.1 Layout Guidelines

To ensure reliability of the device, following common printed-circuit board layout guidelines are recommended:

- Use bypass capacitors on the power supply pins and place them as close to the device as possible. A 0.1 µF capacitor is recommended, but transient performance can be improved by having both 1 µF and 0.1 µF capacitors in parallel as bypass capacitors.
- The high drive capability of this device creates fast edges into light loads so routing and load conditions should be considered to prevent ringing.

11.2 Layout Example

图 **11-1. Layout Example**

Product Folder Links: *SN74AXC4T774-Q1*
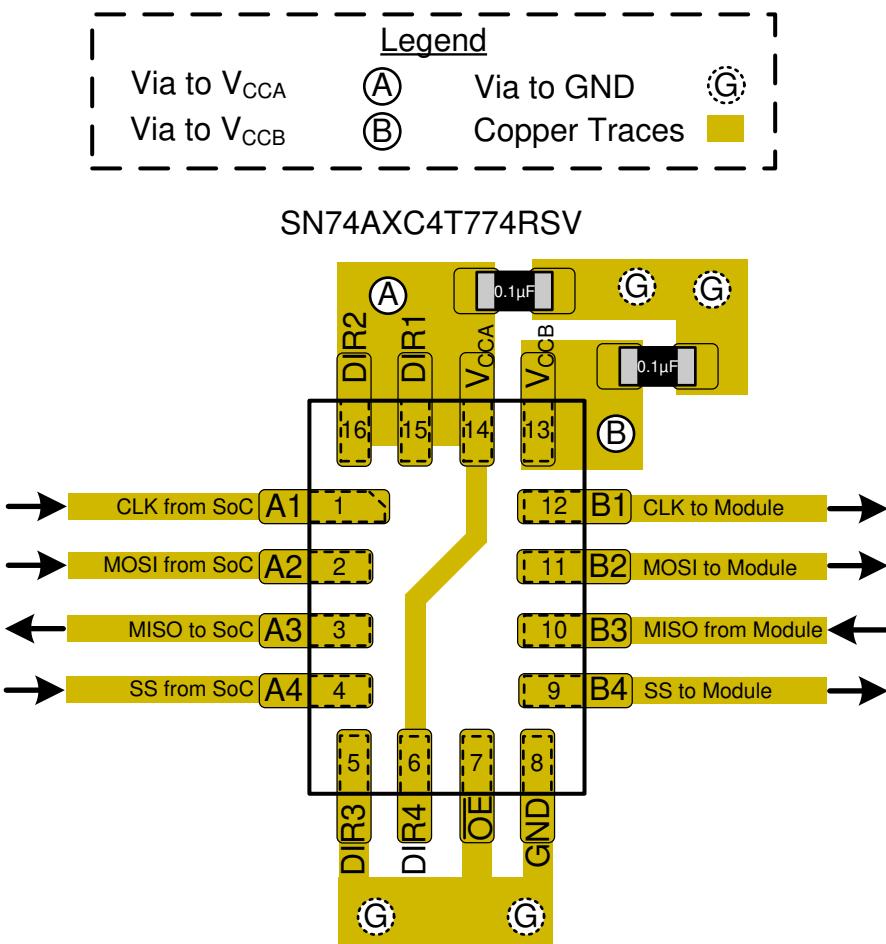
12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

Texas Instruments, *Implications of Slow or Floating CMOS Inputs* application report

Texas Instruments, *Power Sequencing for AXC Family of Devices* application report

Texas Instruments, *SN74AXC4T774 Evaluation Module Tool Folder*

12.2 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击*订阅更新*进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

12.3 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

12.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
所有商标均为其各自所有者的财产。

12.5 静电放电警告

静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.6 术语表

TI 术语表   本术语表列出并解释了术语、首字母缩略词和定义。

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CAXC4T774QBQBRQ1	ACTIVE	WQFN	BQB	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	4T774Q	Samples
CAXC4T774QRSVRQ1	ACTIVE	UQFN	RSV	16	3000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	25ZR	Samples
SN74AXC4T774QPWRQ1	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	4T774Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74AXC4T774-Q1 :

- Catalog : SN74AXC4T774

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION

REEL DIMENSIONS

Reel Diameter

Reel Width (W1)

TAPE DIMENSIONS

K0 P1

Cavity A0 B0 W
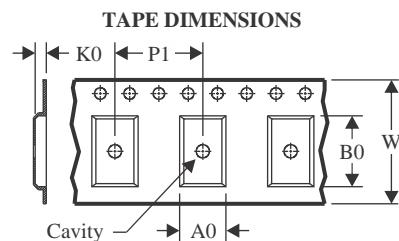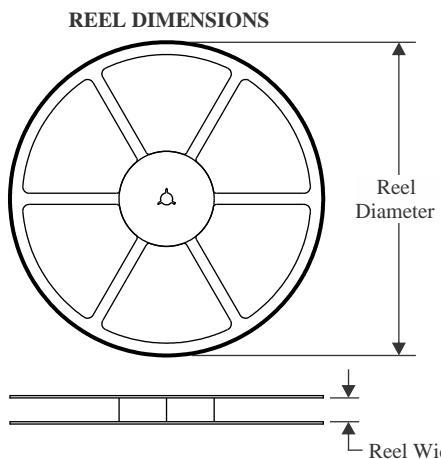
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

Sprocket Holes

| Q1 | Q2 |
| Q3 | Q4 |

User Direction of Feed

Pocket Quadrants
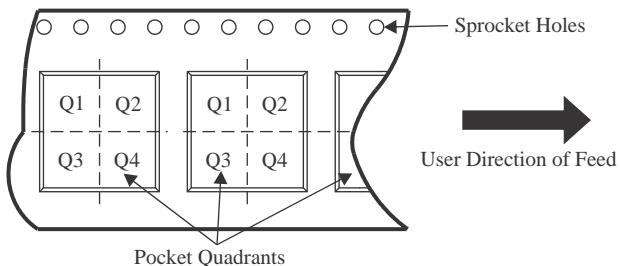
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CAXC4T774QBQBRQ1	WQFN	BQB	16	3000	180.0	12.4	2.8	3.8	1.2	4.0	12.0	Q1
CAXC4T774QRSVRQ1	UQFN	RSV	16	3000	178.0	13.5	2.1	2.9	0.75	4.0	12.0	Q1
SN74AXC4T774QPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

TAPE AND REEL BOX DIMENSIONS
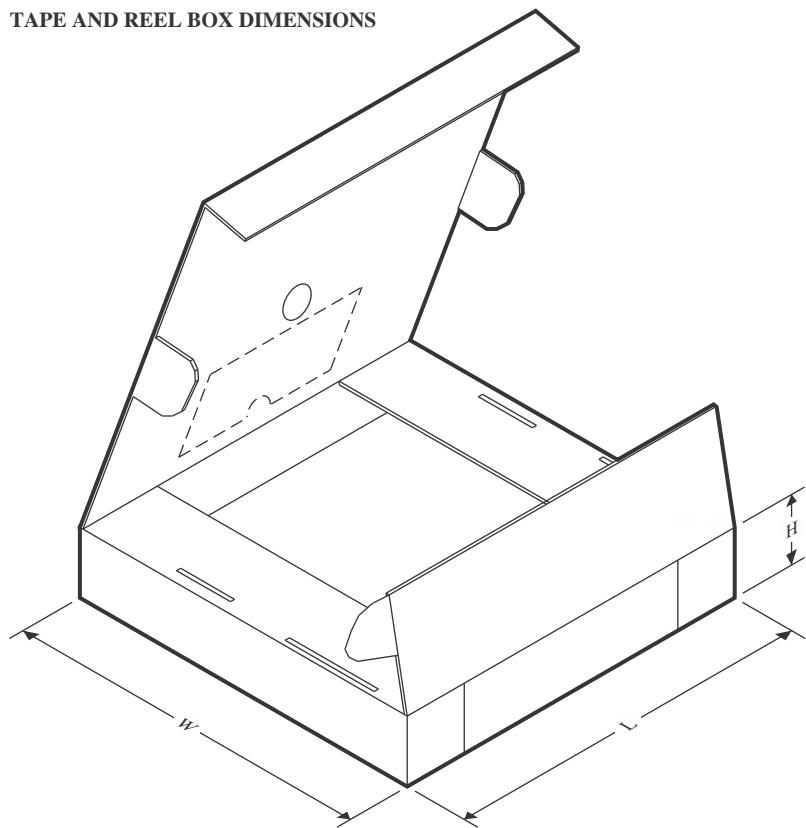
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CAXC4T774QBQBRQ1	WQFN	BQB	16	3000	210.0	185.0	35.0
CAXC4T774QRSVRQ1	UQFN	RSV	16	3000	189.0	185.0	36.0
SN74AXC4T774QPWRQ1	TSSOP	PW	16	2000	356.0	356.0	35.0

B ← 1.85 / 1.75 → A

PIN 1 INDEX AREA

2.65 / 2.55

0.55 / 0.45

0.05 / 0.00

C

SEATING PLANE

⌒ 0.05 C

2X 1.2

SYMM
℄

5   8

15X 0.45 / 0.35

4   9

SYMM
℄

2X 1.2

12X 0.4

1   12

16   13

0.55 / 0.45

PIN 1 ID
(45° X 0.1)

16X 0.25 / 0.15

⊕ 0.07 Ⓜ C A B
  0.05 Ⓜ

(0.13) TYP
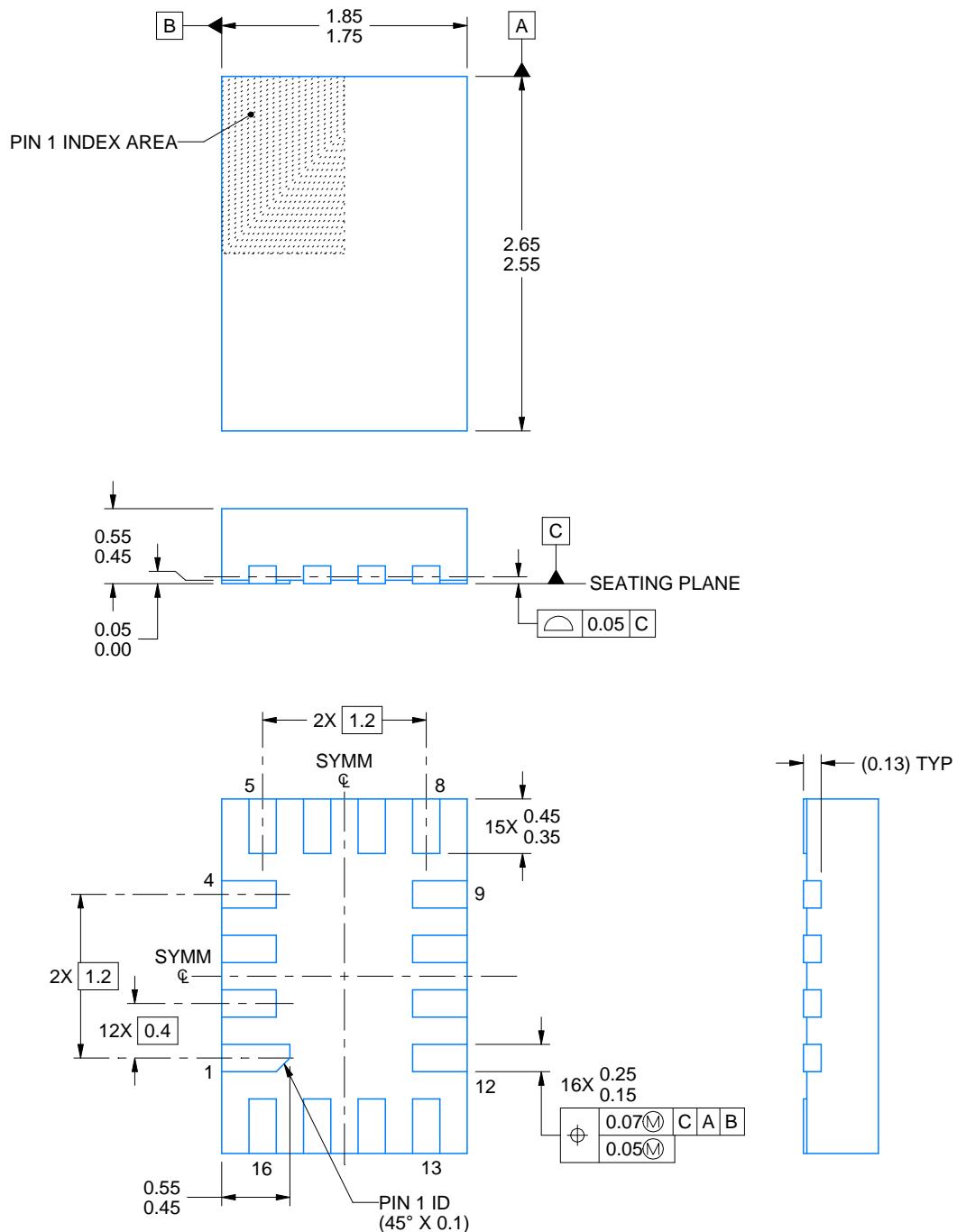
4220314/C   02/2020

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

(0.7)

SYMM

16   13

SEE SOLDER MASK
DETAIL

16X (0.2)   1

12

12X (0.4)

SYMM

(2.4)

(R0.05) TYP

4

9

15X (0.6)

5   8

(1.6)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 25X

0.05 MAX
ALL AROUND

METAL EDGE

EXPOSED METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.05 MIN
ALL AROUND

METAL UNDER
SOLDER MASK
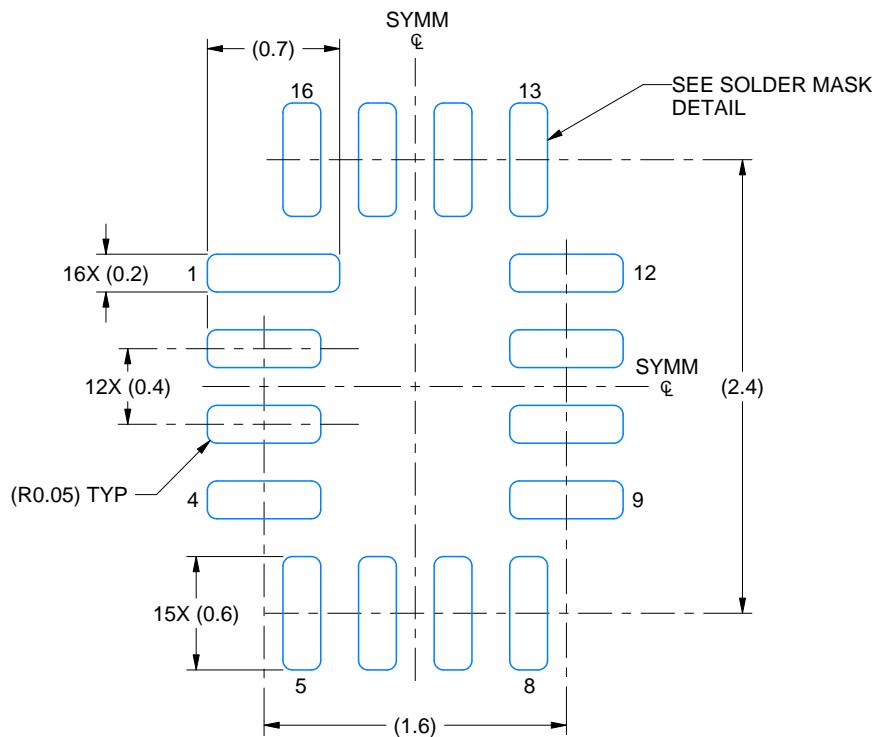
EXPOSED
METAL

SOLDER MASK
OPENING

SOLDER MASK DEFINED
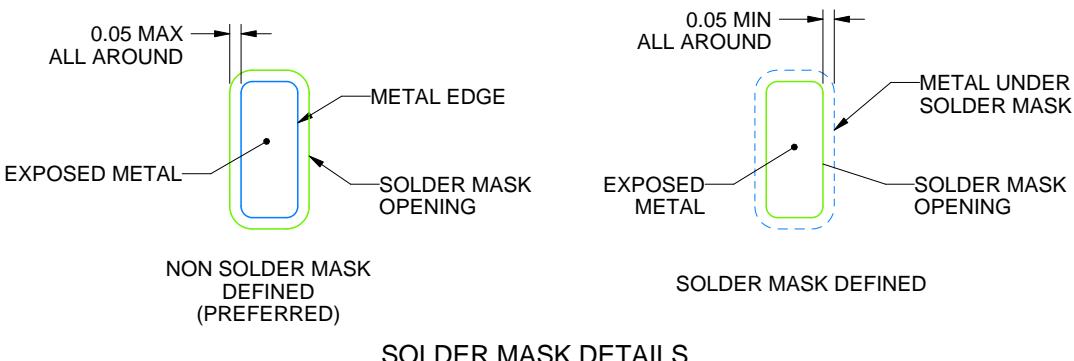
SOLDER MASK DETAILS

4220314/C   02/2020

NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

TEXAS INSTRUMENTS
www.ti.com

RSV0016A

(0.7)

16   13

16X (0.2)   1   12

12X (0.4)

SYMM
℄

(R0.05) TYP

(2.4)

4   9

15X (0.6)

5   8

SYMM
℄

(1.6)
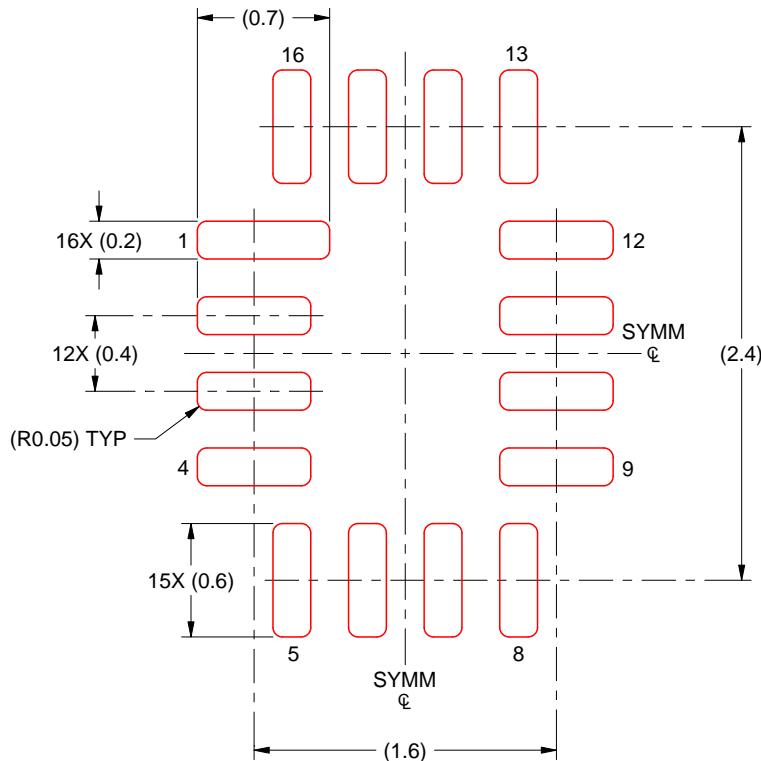
SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 25X

4220314/C   02/2020

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
design recommendations.

6.6
6.2 TYP

A

PIN 1 INDEX AREA

14X 0.65

16

2X
4.55

5.1
4.9
NOTE 3

1

8

9

B

4.5
4.3
NOTE 4

16X 0.30
0.19

$\oplus$ 0.1 Ⓜ C A B

SEATING PLANE

C

◯ 0.1 C

1.2 MAX

SEE DETAIL A

(0.15) TYP

GAGE PLANE

0.25

0° -8°

0.75
0.50

0.15
0.05

DETAIL A
TYPICAL

4220204/A   02/2017
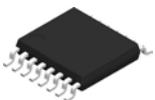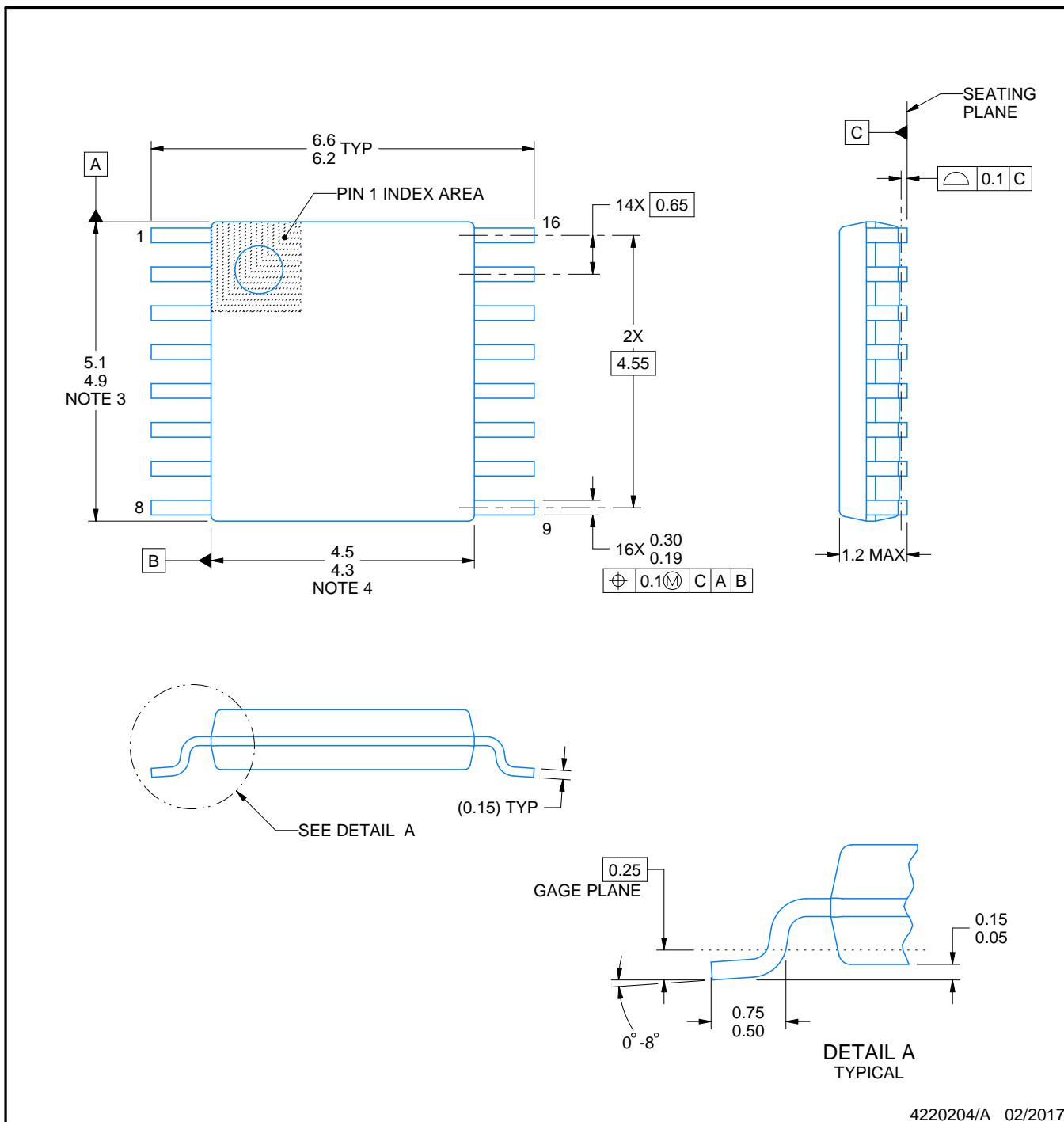
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

TEXAS INSTRUMENTS
www.ti.com

16X (1.5)

SYMM

1

16X (0.45)

(R0.05) TYP

16

SYMM

14X (0.65)

8

9

(5.8)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK
OPENING

METAL

EXPOSED METAL

0.05 MAX
ALL AROUND

NON-SOLDER MASK
DEFINED
(PREFERRED)

METAL UNDER
SOLDER MASK

SOLDER MASK
OPENING

EXPOSED METAL

0.05 MIN
ALL AROUND

SOLDER MASK
DEFINED

SOLDER MASK DETAILS
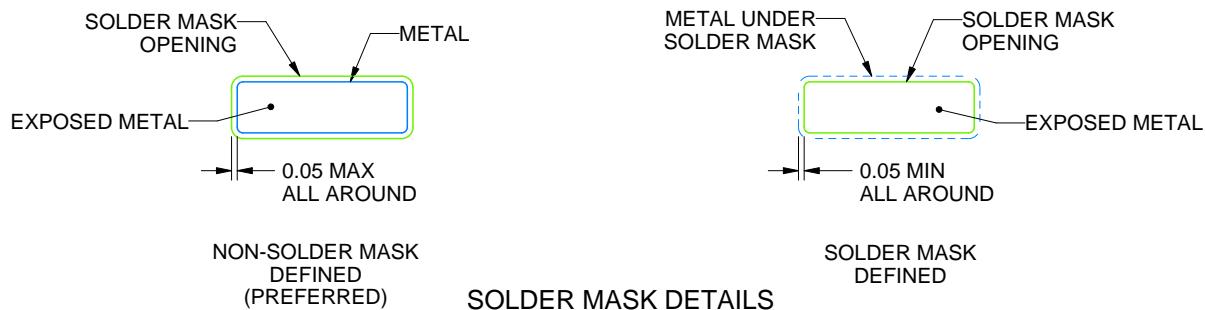
4220204/A   02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

16X (1.5)

SYMM

1

16X (0.45)

(R0.05) TYP

16

SYMM

14X (0.65)

8

9

(5.8)
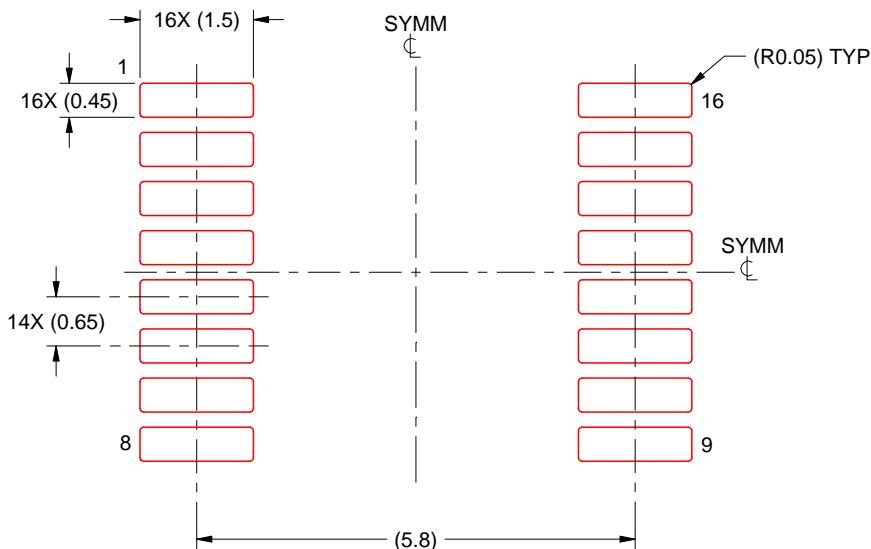
SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/A   02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
   design recommendations.
9. Board assembly site may have different recommendations for stencil design.

BQB 16

2.5 x 3.5, 0.5 mm pitch

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.
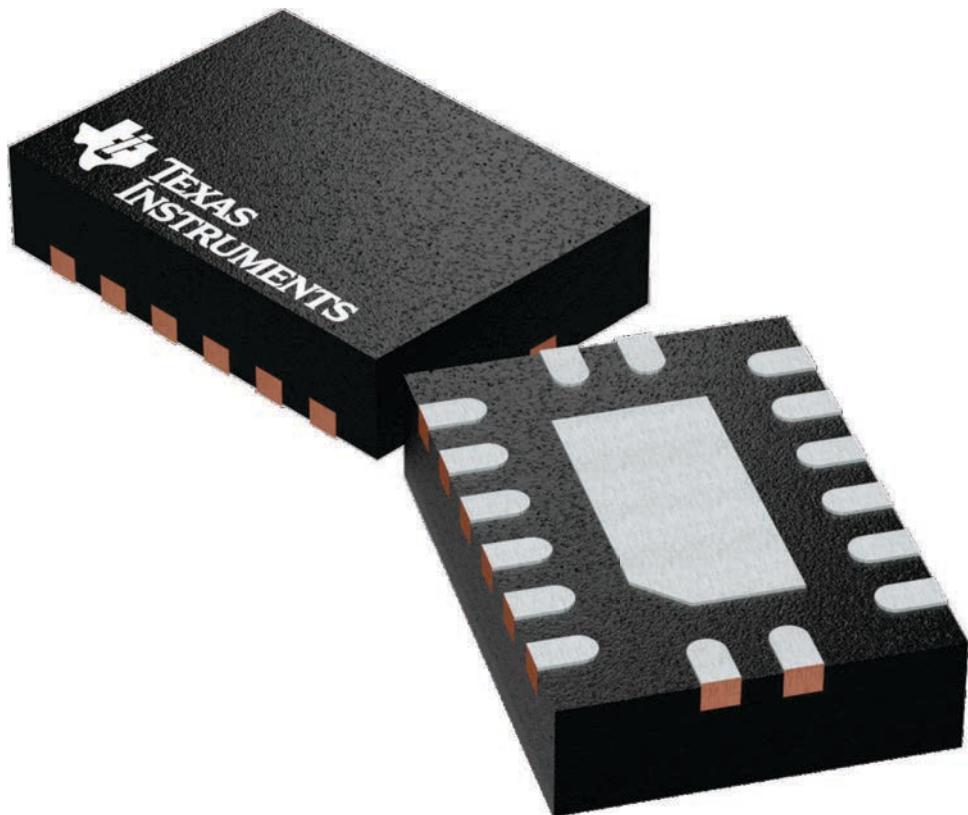
4226161/A

PIN 1 INDEX AREA

2.6 / 2.4

3.6 / 3.4

0.8 / 0.7

0.05 / 0.00

SEATING PLANE

0.08 C

1.1 / 0.9

2X 0.5

10X 0.5

2X 2.5

SYMM

2.1 / 1.9

(0.2) TYP

16X 0.30 / 0.18

16X 0.5 / 0.3

PIN 1 ID (OPTIONAL)

SYMM

0.1 (M) C A B

0.05 (M) C
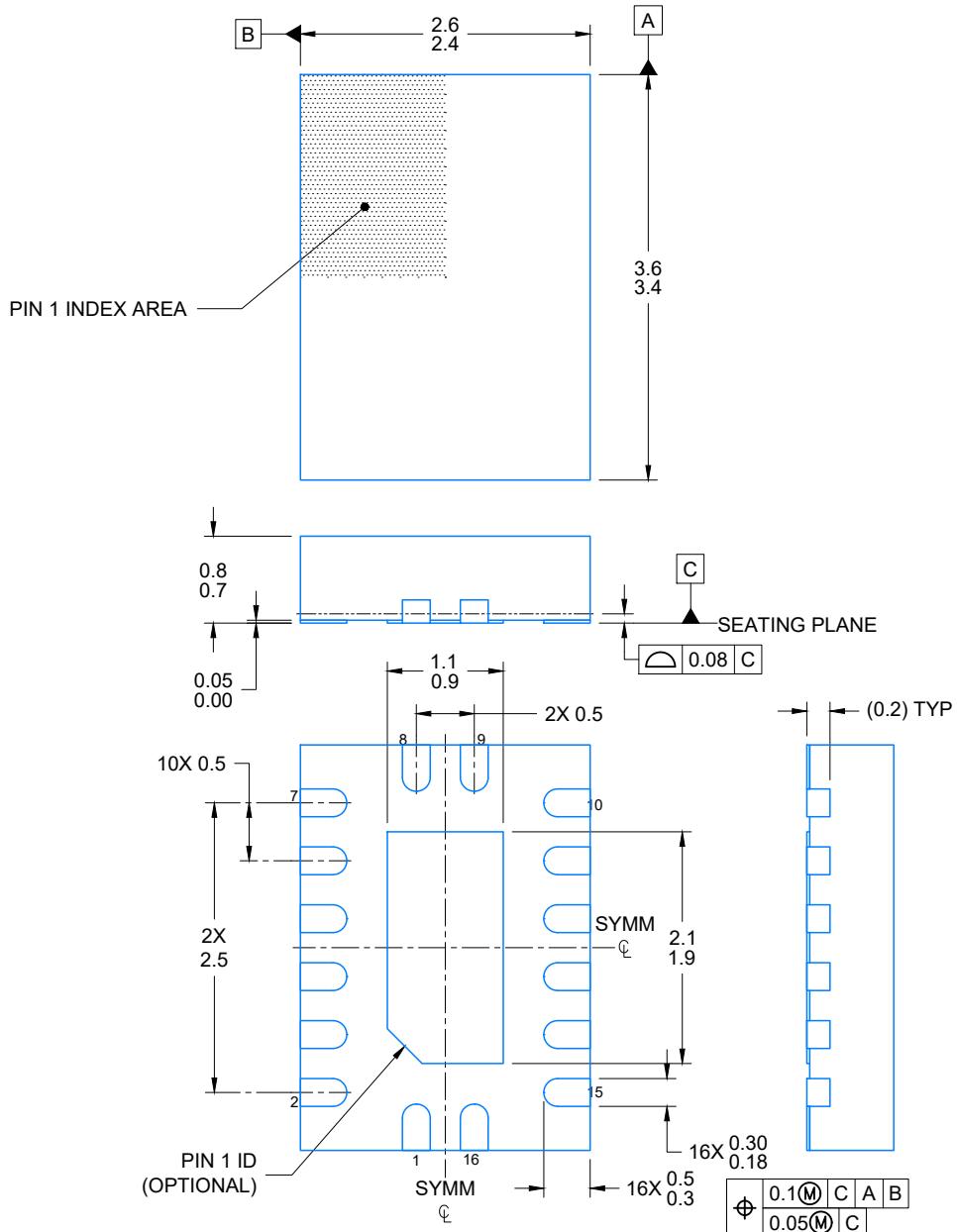
4224640/A   11/2018

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X

0.07 MAX
ALL AROUND

METAL

EXPOSED METAL

SOLDER MASK
OPENING

NON-SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

METAL UNDER
SOLDER MASK

EXPOSED METAL

SOLDER MASK
OPENING

SOLDER MASK
DEFINED
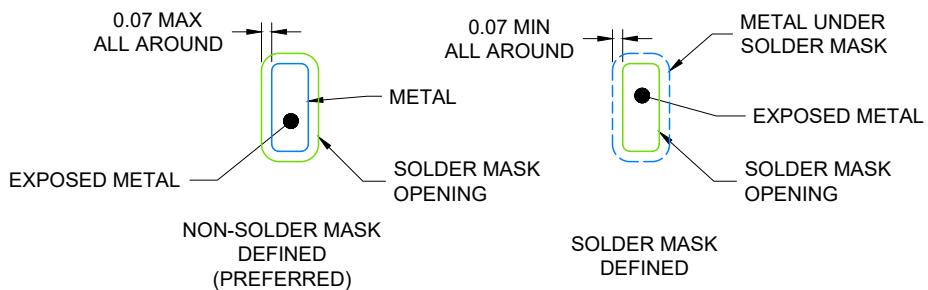
4224640/A   11/2018

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271) .

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
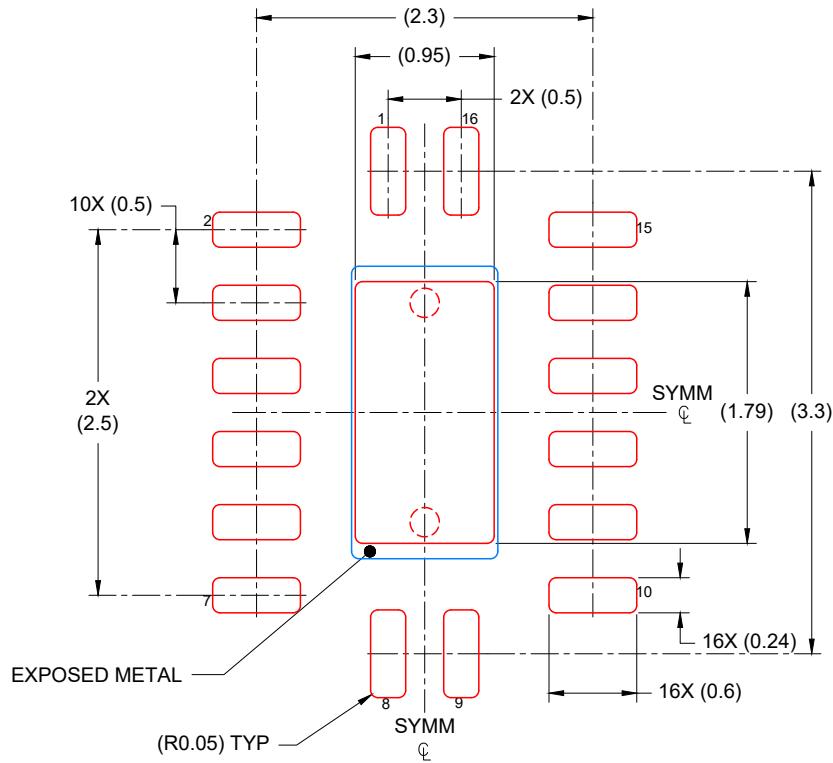
SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
85% PRINTED COVERAGE BY AREA
SCALE: 20X

4224640/A   11/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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